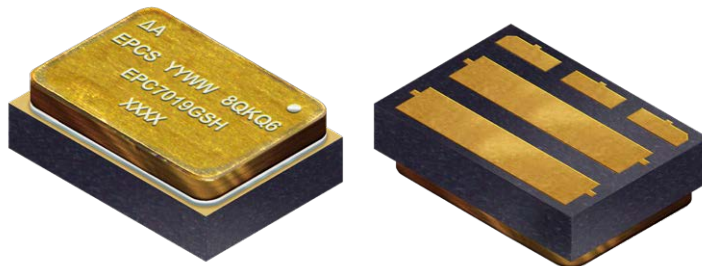


Features

- Ultra-low Q_G For High Efficiency
- Logic Level
- Light Weight
- Compact Hermetic Package
Dual Gate
- Source Sense Pin
- Total Ionizing Dose LDR Immune
- Total Ionizing Dose HDR Immune
- Single Event Effect (SEE) Hardened
 - SEE immunity up to LET of 84 MeV/mg/cm² with V_{DS} up to 100% of rated Breakdown
- Neutron
 - Maintains Pre-Rad specification for up to 4×10^{15} Neutrons/cm²



EPC7019GC

**Rad-Hard eGaN® 40 V, 90 A,
4.5 mΩ Surface Mount (FSMD-G)**

Description

EPC Space FSMD-G series of eGaN® power switching HEMTs have been specifically designed for critical applications in Space and other the high reliability environments. These devices have exceptionally high electron mobility and a low temperature coefficient resulting in very low $R_{DS(on)}$ values. The lateral structure of the die provides for very low gate charge (Q_G) and extremely fast switching times. These features enable faster power supply switching frequencies resulting in higher power densities, higher efficiencies and more compact packaging.

Applications

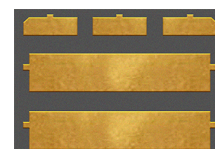
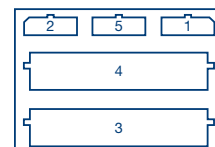
- Satellite and Avionics
- Deep Space Probes
- High Speed Rad-Hard DC-DC Conversion
- Rad-Hard Motor Controllers
- Nuclear Facilities

Thermal Characteristics

Symbol	Parameter-Conditions	Value	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 3)	48	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case	1.55	

I/O Pin Assignment (Bottom View)

Pin	Symbol	Description
1	G	Gate
2	G	Gate
3	D	Drain
4	S	Source
5	SS	Source Sense



Absolute Maximum Rating ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter-Conditions	Value	Units
V_{DS}	Drain to Source Voltage (Note 1)	40	V
	Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	48	
I_D	Continuous Drain Current I_D @ $V_{GS} = 5$ V	90	A
I_{DM}	Single-Pulse Drain Current $t_{pulse} = 300 \mu\text{s}$	477	
V_{GS}	Gate to Source Voltage (Note 2)	+6 / -4	V
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C
T_{SOL}	Package Mounting Surface Temperature	260	
ESD	ESD Class	1B (ΔB)	
Weight	Device Weight	0.170	g

Static Characteristics (Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units	
Drain to Source Voltage	B_{VDSS}	$V_{GS} = 0\text{ V}$	40			V	
Drain to Source Leakage	I_{DSS}	$V_{DS} = 40\text{ V}$		0.001	0.4	mA	
		$V_{GS} = 0\text{ V}$	$T_C = 125^\circ\text{C}$	0.01	0.8		
Gate to Source Forward Leakage	I_{GSSF}	$V_{GS} = 5\text{ V}$		0.05	0.5	mA	
Gate to Source Forward Leakage [#]		$V_{GS} = 5\text{ V}$	$T_C = 125^\circ\text{C}$	0.2	1		
Gate to Source Reverse Leakage	I_{GSSR}	$V_{GS} = -4\text{ V}$		0.05	0.5		
Gate to Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 18\text{ mA}$	$T_C = 25^\circ\text{C}$	0.8	1.4	2.5	V
Gate to Source Threshold Voltage Temperature Coefficient	$\Delta V_{GS(th)}$		$-55^\circ\text{C} < T_A < 150^\circ\text{C}$		2.0		mV/°C
Drain to Source Resistance (Note 4)	$R_{DS(on)}$	$V_{GS} = 5\text{ V}, I_D = 50\text{ A}$		3.7	4.5	mΩ	
Source to Drain Forward Voltage	V_{SD}	$I_S = 0.5\text{ A}, V_G = 0\text{ V}$		2	3	V	

Dynamic Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise noted. Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units
Input Capacitance	C_{ISS}	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$		2830		pF
Reverse transfer Capacitance	C_{RSS}			35		
Output Capacitance	C_{OSS}			1660		
Effective Output Capacitance, Energy Related	$C_{OSS(ER)}$	$V_{DS} = 0\text{ to }20\text{ V}, V_{GS} = 0\text{ V}$		2130		pF
Effective Output Capacitance, Time Related	$C_{OSS(TR)}$			2540		
Total Gate Charge (Note 5)	Q_G	$V_{DS} = 0\text{ to }20\text{ V}, V_{GS} = 0\text{ V}, I_D = 50\text{ A}$		22		nC
Gate to Source Charge (Note 5)	Q_{GS}	$V_{DS} = 20\text{ V}, I_D = 50\text{ A}$		9.1		
Gate to Drain Charge (Note 5)	Q_{GD}			3.4		
Output Charge (Note 5)	Q_{OSS}	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$		51		
Source to Drain Recovery Charge (Note 6)	Q_{RR}			0		

Figure 1: Typical Output Characteristics at 25°C

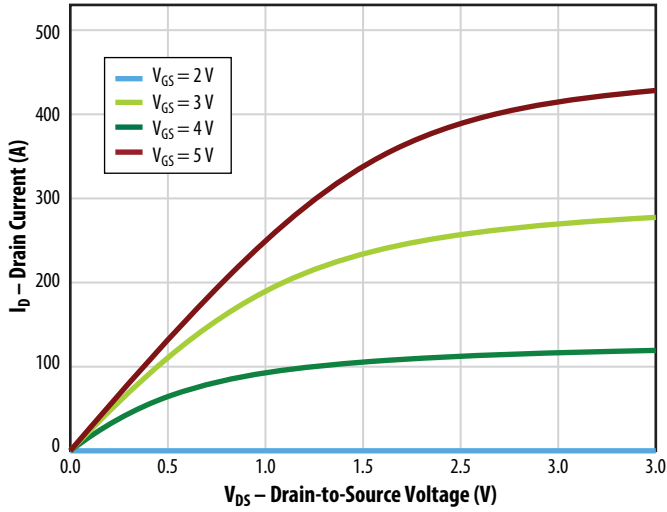


Figure 2: Typical Output Characteristics at 125°C

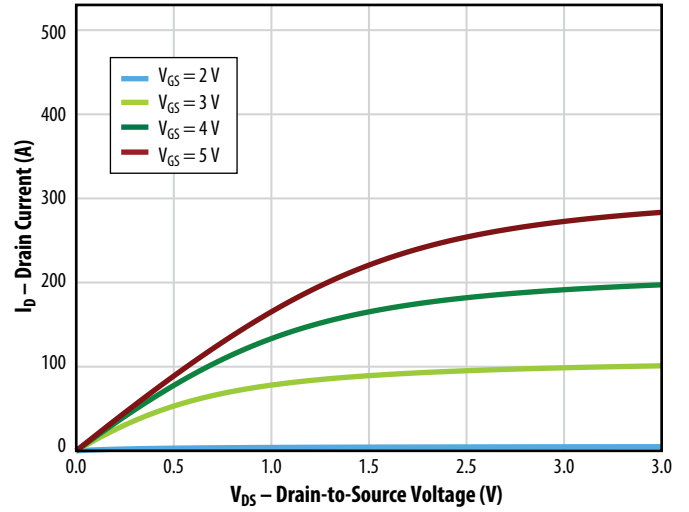


Figure 3: Typical Transfer Characteristics

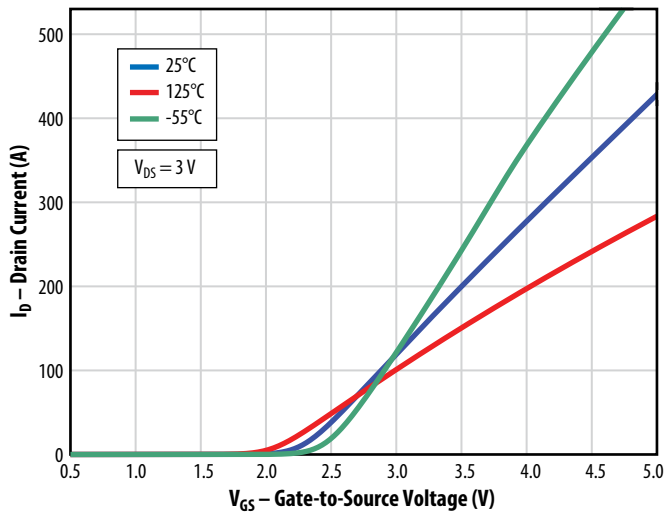


Figure 4: Reverse Drain-Source Characteristics

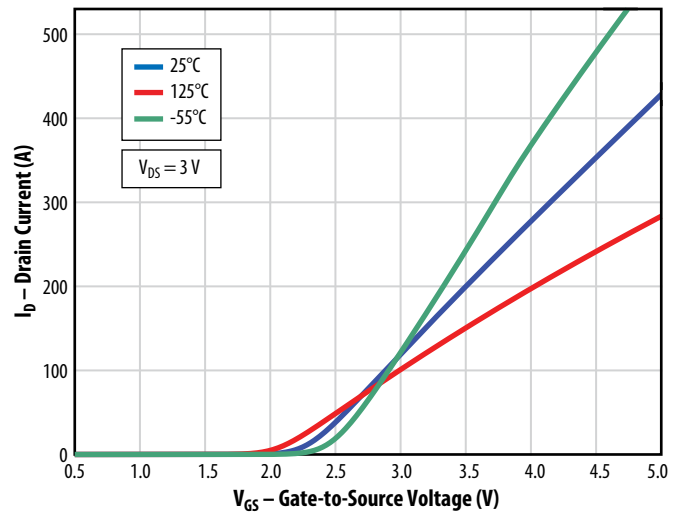


Figure 5: $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

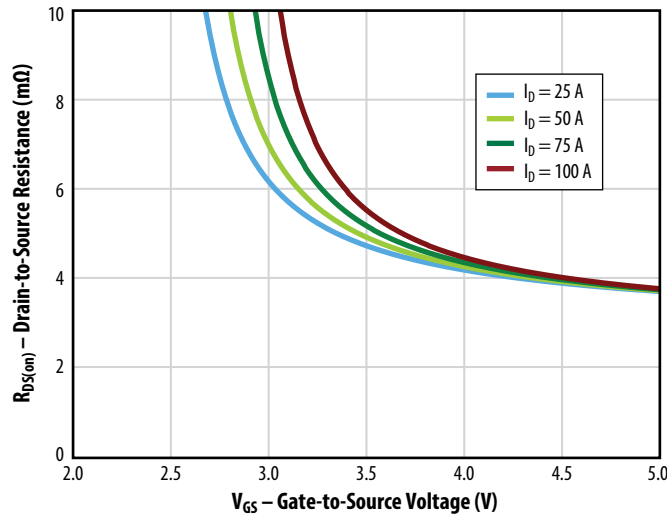


Figure 6: $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

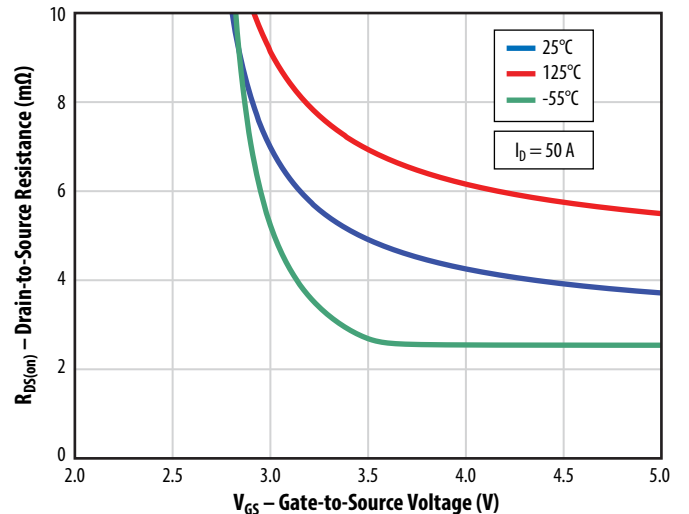


Figure 7: Normalized On-State Resistance vs. Temp.

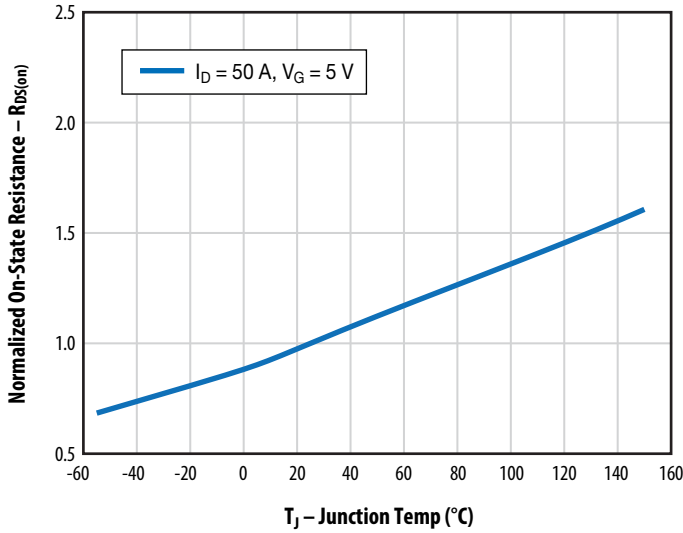


Figure 8: Normalized On-State Resistance vs. Temp.

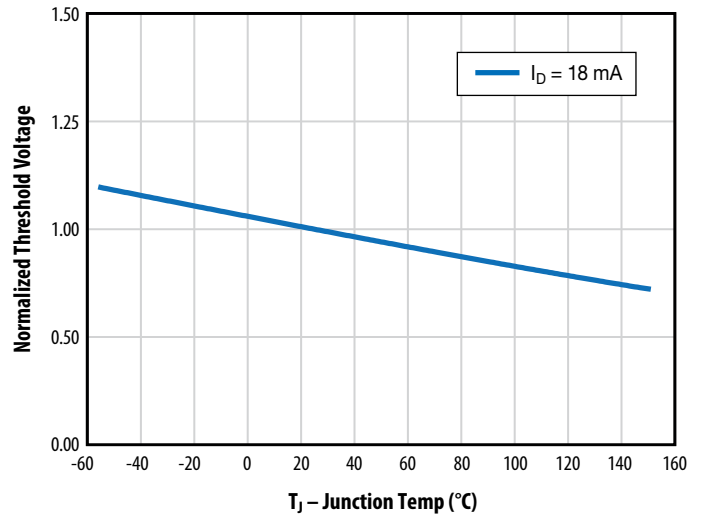


Figure 9: Typical Capacitance

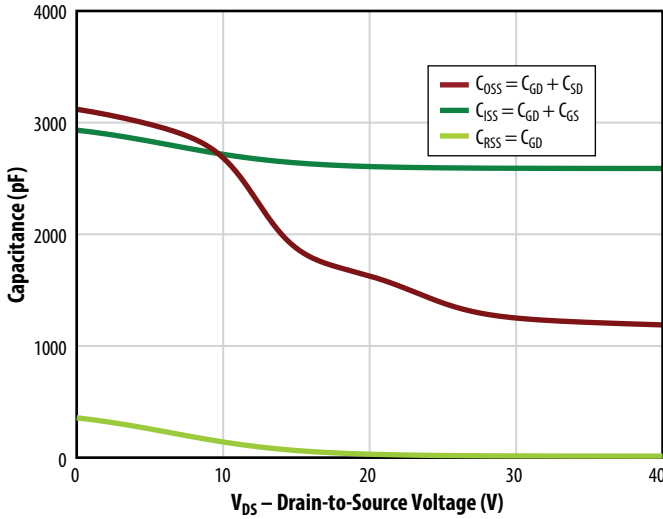


Figure 10: Typical Output Charge and C_{OSS} Stored Energy

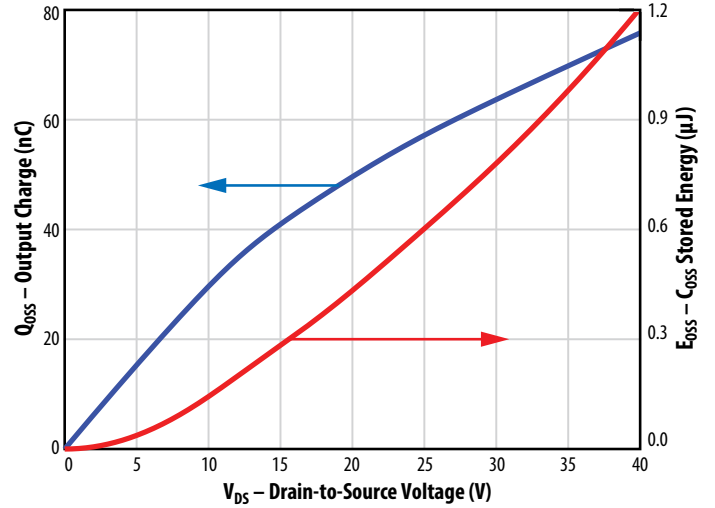
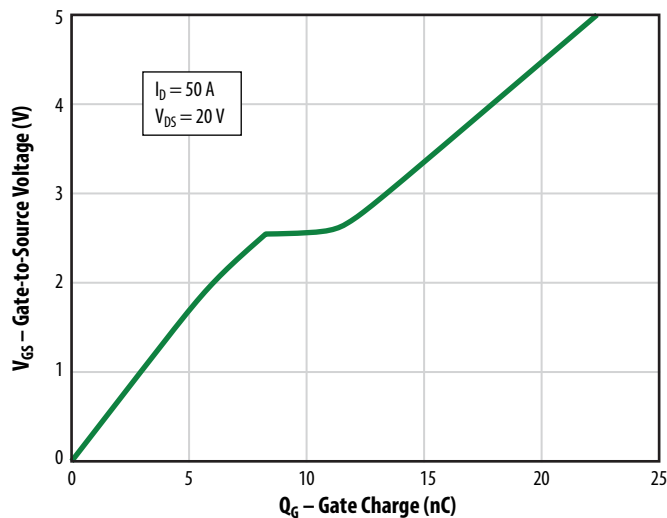
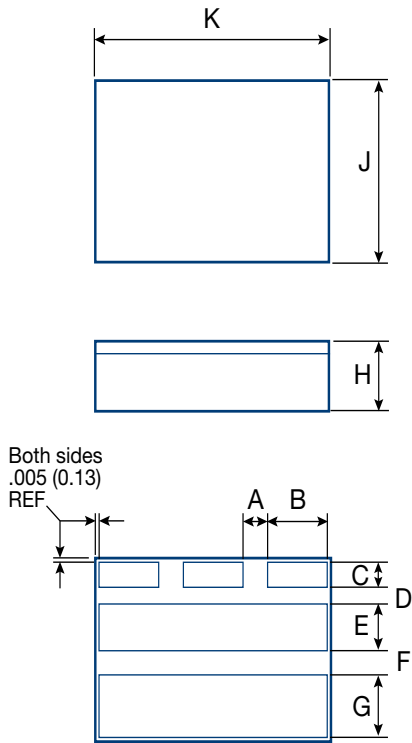


Figure 10: Typical Capacitance

Figure 11: Typical Gate Charge



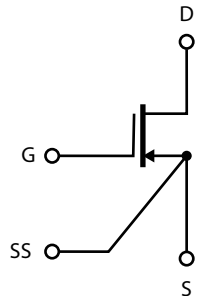
Package Outline and Dimensions



Symbol	Inches		Millimeters		Note
	MIN	MAX	MIN	MAX	
A (2x)	0.028	0.038	0.711	0.965	
B (3x)	0.075	0.085	1.905	2.159	
C (3x)	0.025	0.035	0.635	0.889	
D	0.015	0.025	0.381	0.635	
E	0.051	0.061	1.295	1.549	
F	0.024	0.034	0.61	0.864	
G	0.07	0.08	1.778	2.032	
H	0.078	0.088	1.981	2.235	
J	0.215	0.225	5.461	5.715	
K	0.311	0.321	7.899	8.153	

Standard Terminal Pad finish is a solder alloy of 63%Pb 37%Sn

Package Connections



NOTE: SS pin is connected directly to source of internal die.

Notes

- Note 1. Never exceed the absolute maximum V_{DS} of the device otherwise permanent damage/destruction may result.
- Note 2. Never exceed the absolute maximum V_{GS} of the device otherwise permanent damage/destruction may result. We recommend a V_{GS} of 5 V for optimum operation across life and radiation.
- Note 3. $R_{\theta JA}$ measured with FSMD-G package mounted to double-sided PCB, 0.063" thickness with 1.0 square inches of copper area on the top (mounting side) and a flood etch (3 square inches) on the bottom side.
- Note 4. Measured using four wire (Kelvin) sensing and pulse measurement techniques. Measurement pulse width is 80 μ s and duty cycle is 1%, maximum.
- Note 5. Guaranteed by design/device construction. Not tested.
- Note 6. The gate charge parameters are measured based on the MIL-STD-750.3471 Condition B. A high speed constant gate current (I_{const}) is provided to the Gate of the DUT during the time that the ground switch (G_S) is OFF (t_{off}). The DUT is switched ON and OFF using ground-sensed switch G_S . The gate current is adjusted to yield the desired charge per unit time ($I_{const} \cdot \text{time per division}$) on the measuring oscilloscope. The G_S pulse drive ON time (t_{on}) is adjusted for the desired observability of the gate-source voltage (V_{GS}) waveform. The maximum duty cycle of the ground switch (t_{off}/t_{on}) should be set to 1% maximum. Please note that all gate-related signals are referenced to the "Source Sense" pin on the package. At all times during the measurement, the maximum gate-source voltage is clamped to 5 V_{DC} .

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